WMSC020H12B1P

N-Channel Silicon Carbide MOSFET Module

Rev.02 - 24 September 2024 Product data sheet

1. General description

WeEnPACK-B1 module with WeEn 1200V Gen2 SiC MOSFET and PressFit pin type. Intergrated with NTC temperature sensor.

RoHS Halogen-Free Lead-Free

2. Features and benefits

- Half bridge topology
- PressFit pins technology
- Low R_{DSon}
- Low Switching Losses
- Low Q_g and C_{rss}
- Low Inductive Design

3. Applications

- Power inverters
- AC-DC converters
- DC-DC converters
- Active power factor correctors
- Motor drivers

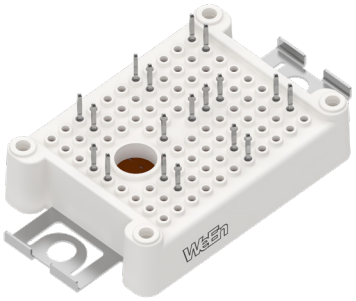
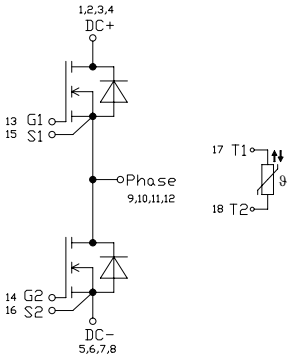
4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Notes	Values			Unit
Absolute maximum rating							
V_{DS}	drain-source voltage	T_j = 25 °C		1200			V
I_D	drain current	V_{GS} = 18 V; T_h = 25 °C		70			A
P_{tot}	total power dissipation	T_h = 25 °C		118			W
$T_{j.op}$	junction temperature			-40 to 150			°C
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
Static characteristics							
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 15 V; I_D = 50 A; T_j = 25 °C		-	20	-	mΩ
		V_{GS} = 18 V; I_D = 50 A; T_j = 25 °C		-	15.9	29	mΩ
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 50 A; V_{DS} = 800 V; V_{GS} = -4 V/18 V; T_j = 25 °C		-	232	-	nC
Q_{GD}	gate-drain charge			-	44	-	nC
Source-drain diode							
Q_r	recovered charge	I_{SD} = 50 A; V_{GS} = -4 V; di/dt = 8500 A/µs; V_R = 600 V; T_j = 25 °C		-	810	-	nC

5. Pinning information

Table 2. Pinning information

Simplified outline	Circuit diagram
 * Please refer to the package outline description for actual pin order.	

6. Ordering information

Table 3. Ordering information

Type number	Package Name	Orderable part number	Packing method	Small packing quantity	Package version	Package issue date
WMSC020H12B1P	WeEnPACK-B1	WMSC020H12B1P6T	Tray	16	WeEnPACK-B1PHB-A	14-Dec-2023

7. Marking

Table 4. Marking codes

Type number	Marking codes
WMSC020H12B1P	WMSC020H12B1P

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Notes	Values	Unit
T_{stg}	storage temperature			-40 to 125	°C
$T_{j.op}$	operating junction temperature			-40 to 150	°C
$T_{j.max}$	maximum junction temperature	Intermittent condition with shortened lifetime		-40 to 175	°C
V_{ISOL}	RMS isolation voltage	T_j = 25 °C; all terminals shorted; f = 50 Hz; t = 1 s		3500	V
MOSFET					
V_{DS}	drain-source voltage	T_j = 25 °C		1200	V
$V_{GS,max}$	gate-source voltage	Absolute maximum values		-12 to 24	V
$V_{GS,op}$	gate-source voltage	Recommended operational values		-4 to 18	V
P_{tot}	total power dissipation	T_h = 25 °C		118	W
I_D	drain current	V_{GS} = 18 V; T_h = 25 °C		70	A
		V_{GS} = 18 V; T_h = 100 °C		44	A
I_{DM}	peak drain current	pulse width t_p limited by T_{jmax}	Fig.17	140	A
E_{as}	single pulse drain−to-source avalanche	I_{AS} = 24 A; L = 1 mH; V_{DD} = 100 V; $T_{j(init)}$ = 25 °C; per MOSFET		288	mJ
Body Diode					
I_{SD}	DC body diode forward current	V_{GS} = -4 V; T_h = 25 °C		28	A
$I_{SD,pulse}$	Pulse body diode current	verified by design, t_p limited by T_{jmax}		140	A

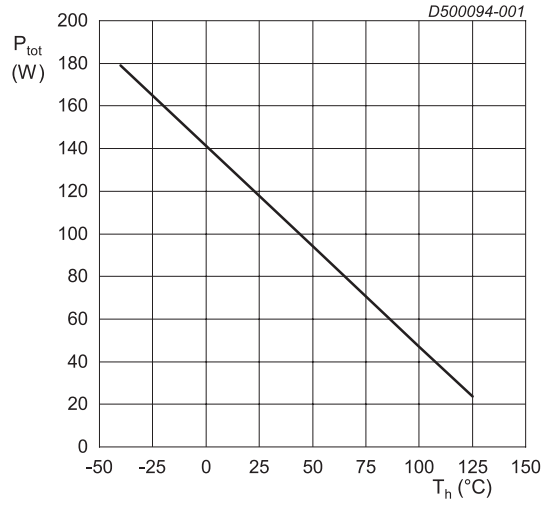


Fig. 1. Power dissipation as a function of heatsink temperature; maximum values

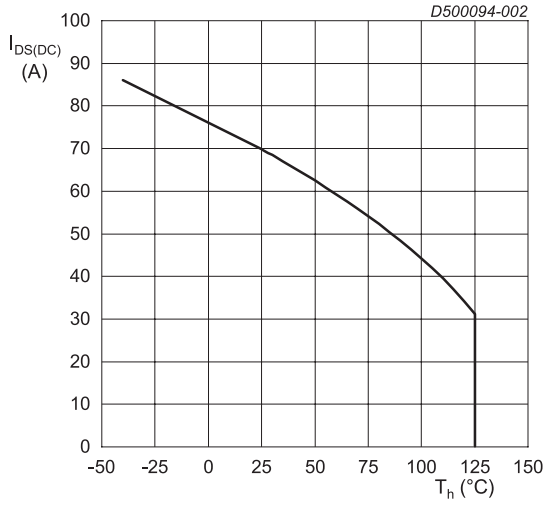


Fig. 2. Continuous Drain Current as a function of heatsink temperature

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Notes	Min	Typ	Max	Unit
$R_{th(j-c)}$	thermal resistance from junction to case	per MOSFET		-	0.38	-	K/W
$R_{th(j-h)}$	thermal resistance from junction to heatsink	per MOSFET, λ_{grease} = 1 W/(m·K)		-	1.06	-	K/W
Internal Isolation		basic insulation (class 1, IEC 61140)			Al_2O_3		
d_{Creep}	Creepage distance	terminal to heatsink		-	11.5	-	mm
		terminal to terminal		-	6.3	-	mm
d_{Clear}	Clearance	terminal to heatsink		-	10	-	mm
		terminal to terminal		-	5	-	mm
CTI	Comperative tracking index				>200		
F	Mounting force per clamp			20	-	50	N
G	Approximate Weight			-	20	-	g

Note: Module is ESD sensitive. Handling precautions are recommended.

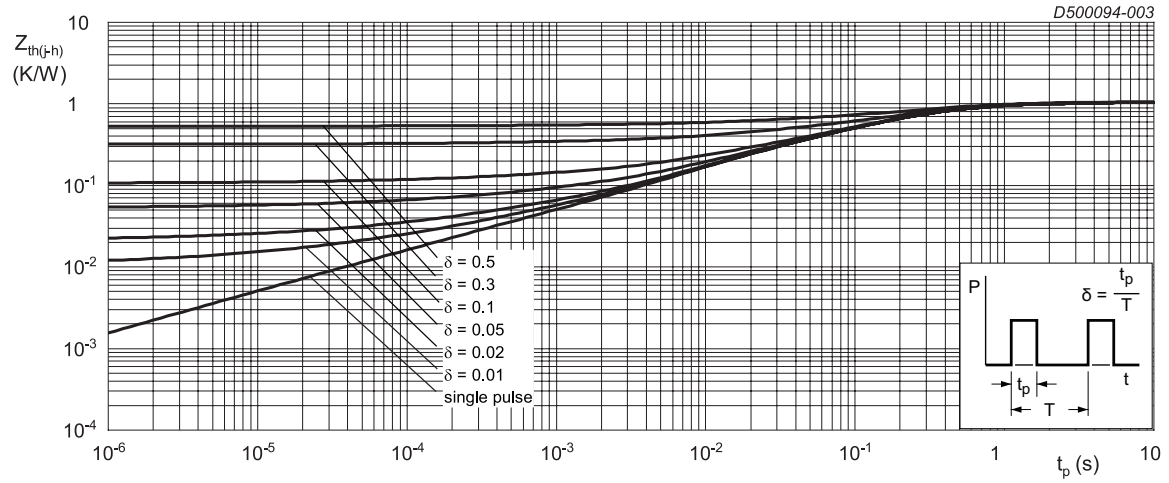


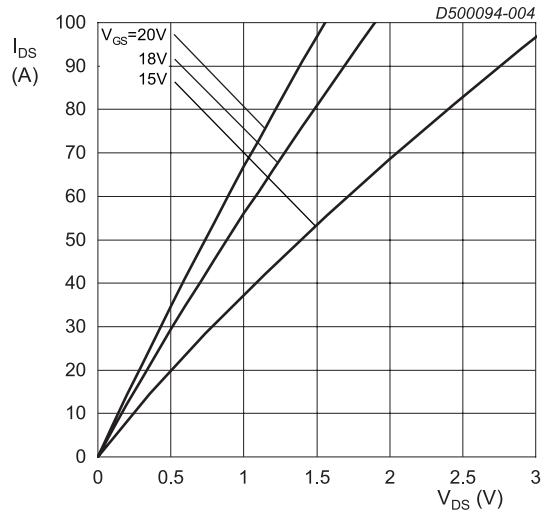
Fig. 3. Transient thermal impedance from junction to heatsink as a function of pulse duration

10. Characteristics

Table 7. Characteristics

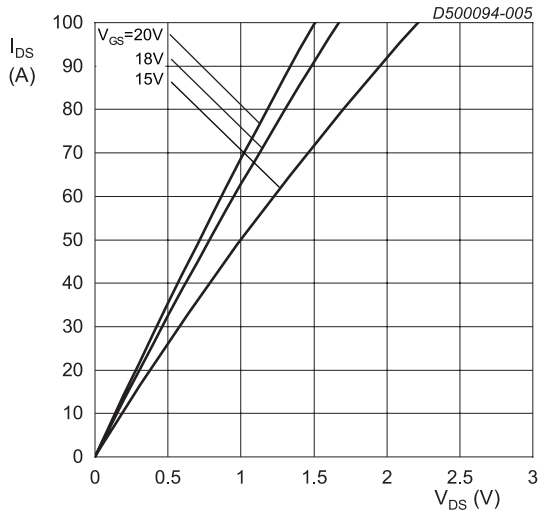
MOSFET							
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
Static characteristics							
$V_{(BR)DSS}$	drain-source breakdown voltage	I_D = 200 µA; V_{GS} = 0 V; T_j = 25 °C		1200	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	I_D = 20 mA; V_{DS} = 10 V; T_j = 25 °C		1.9	2.5	3.5	V
		I_D = 20 mA; V_{DS} = 10 V; T_j = 175 °C		-	1.9	-	V
I_{DSS}	drain leakage current	V_{DS} = 1200 V; V_{GS} = 0 V; T_j = 25 °C		-	0.4	200	µA
I_{GSS}	gate leakage current (absolute value)	V_{GS} = 24 V; V_{DS} = 0 V; T_j = 25 °C		-	20	200	nA
		V_{GS} = -12 V; V_{DS} = 0 V; T_j = 25 °C		-	20	200	nA
$R_{DS(on)}$	drain-source on-state resistance	V_{GS} = 15 V; I_D = 50 A; T_j = 25 °C		-	20	-	mΩ
		V_{GS} = 18 V; I_D = 50 A; T_j = 25 °C		-	15.9	29	mΩ
		V_{GS} = 18 V; I_D = 50 A; T_j = 125 °C		-	21.7	-	mΩ
		V_{GS} = 18 V; I_D = 50 A; T_j = 150 °C		-	24.1	-	mΩ
		V_{GS} = 18 V; I_D = 50 A; T_j = 175 °C		-	25.3	-	mΩ
R_G	gate resistance, each side	f = 1 MHz; T_j = 25 °C, each die with 4.7 Ω $R_{G(ext)}$ in series		-	2.9	-	Ω
g_{fs}	transconductance	V_{DS} = 20 V; I_D = 50 A; T_j = 25 °C		-	35	-	S
Dynamic characteristics							
$Q_{G(tot)}$	total gate charge	I_D = 50 A; V_{DS} = 800 V; V_{GS} = -4 V/18 V; T_j = 25 °C		-	232	-	nC
Q_{GS}	gate-source charge			-	86	-	nC
Q_{GD}	gate-drain charge			-	44	-	nC
C_{iss}	input capacitance	V_{DS} = 1000 V; V_{GS} = 0 V; f = 100 KHz; T_j = 25 °C		-	4.8	-	nF
C_{oss}	output capacitance			-	237	-	pF
C_{rss}	reverse transfer capacitance			-	21.3	-	pF
E_{oss}	Coss stored energy			-	118	-	µJ
$t_{d(on)}$	turn-on delay time	V_{DS} = 800 V; V_{GS} = -4 V/18 V; $R_{G(off)}$ = 2.4 Ω; $R_{G(on)}$ = 2.4 Ω; I_D = 50 A; L = 100 µH; T_j = 25 °C		-	22	-	ns
t_r	rise time			-	42	-	ns
$t_{d(off)}$	turn-off delay time			-	68	-	ns
t_f	fall time			-	39	-	ns
E_{on}	turn-on energy			-	0.84	-	mJ
E_{off}	turn-off energy			-	0.4	-	mJ

Body diode							
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
Static characteristics							
V_{SD}	source-drain voltage	V_{GS} = -4 V; I_{SD} = 50 A; T_j = 25 °C		-	5.5	-	V
		V_{GS} = -4 V; I_{SD} = 50 A; T_j = 150 °C		-	4.9	-	V
Dynamic characteristics							
t_{rr}	reverse recovery time	I_{SD} = 50 A; V_{GS} = -4 V; di/dt = 8500 A/µs; V_R = 600 V; T_j = 25 °C		-	19	-	ns
Q_r	recovered charge			-	810	-	nC
I_{rrm}	reverse recovery current			-	71	-	A
E_{rec}	reverse recovery energy			-	345	-	µJ
t_{rr}	reverse recovery time	I_{SD} = 50 A; V_{GS} = -4 V; di/dt = 11000 A/µs; V_R = 600 V; T_j = 150 °C		-	22	-	ns
Q_r	recovered charge			-	1670	-	nC
I_{rrm}	reverse recovery current			-	120	-	A
E_{rec}	reverse recovery energy			-	1135	-	µJ
NTC thermistor							
Symbol	**Parameter**	**Conditions**	**Notes**	**Min**	**Typ**	**Max**	**Unit**
R_{25}	Rated resistance	T_{NTC} = 25 °C		-	5000	-	Ω
R_{100}		T_{NTC} = 100 °C		465±5%			Ω
$B_{25/50}$	B-value	$R_2 = R_{25} \exp[B_{25/50}(1/T_2 - 1/(298.15K))]$		3380			K
	Maximum operating temperature			-	200	-	°C
	Dissipation costant			-	2	-	mW/K
	Thermal time constant			-	≤10	-	s



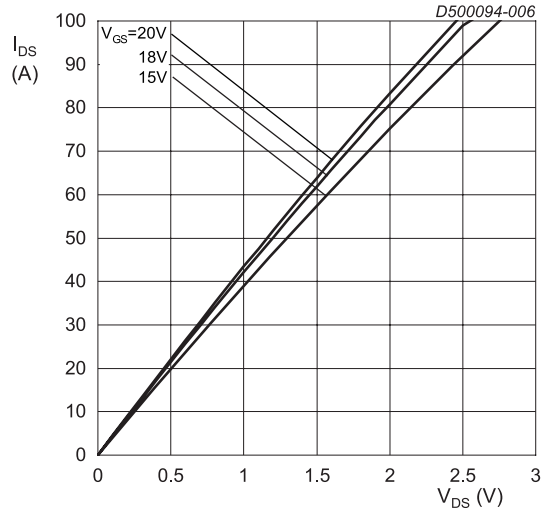
T_j = -40 °C; t_p < 200 µs

Fig. 4. Output characteristics; drain current as a function of drain-source voltage; typical values



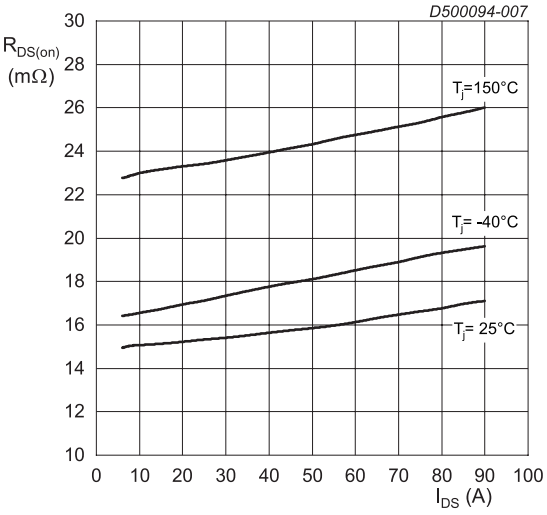
T_j = 25 °C; t_p < 200 µs

Fig. 5. Output characteristics; drain current as a function of drain-source voltage; typical values



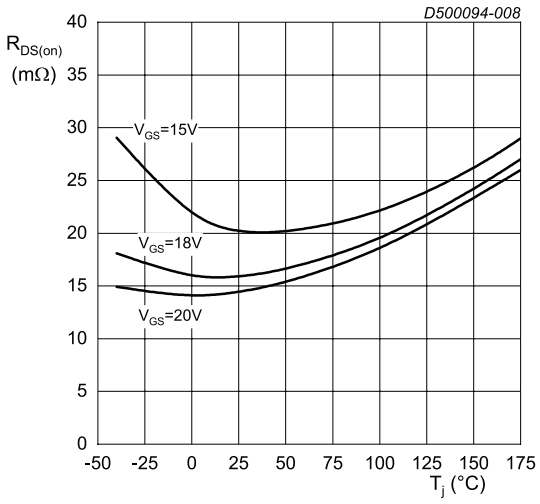
T_j = 150 °C; t_p < 200 µs

Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values



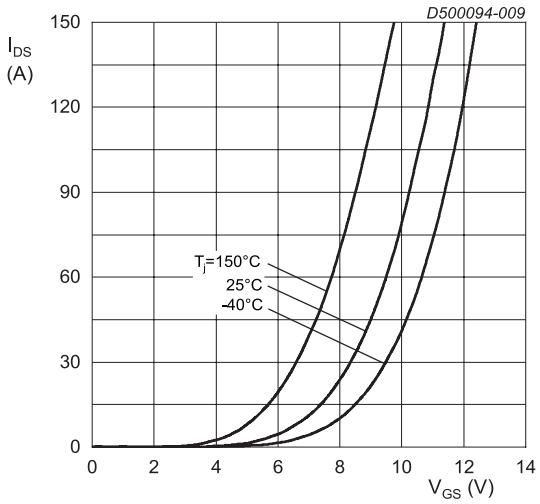
V_{GS} = 18 V; t_p < 200 µs

Fig. 7. Drain-source on-state resistance as a function of drain current; typical values



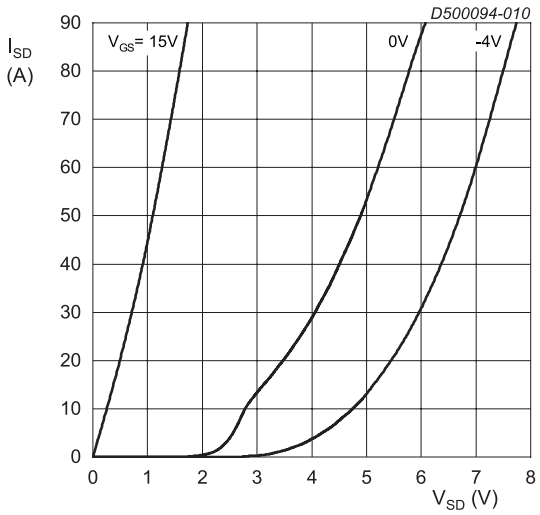
I_{DS} = 50 A; t_p < 200 µs

Fig. 8. Drain-source on-state resistance as a function of junction temperature



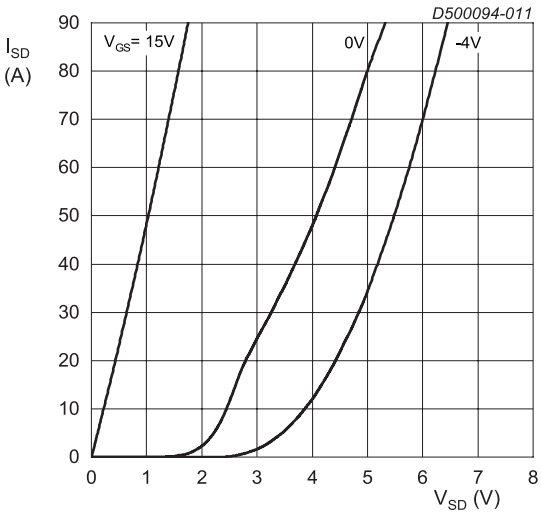
V_{DS} = 20 V; t_p < 200 µs

Fig. 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values



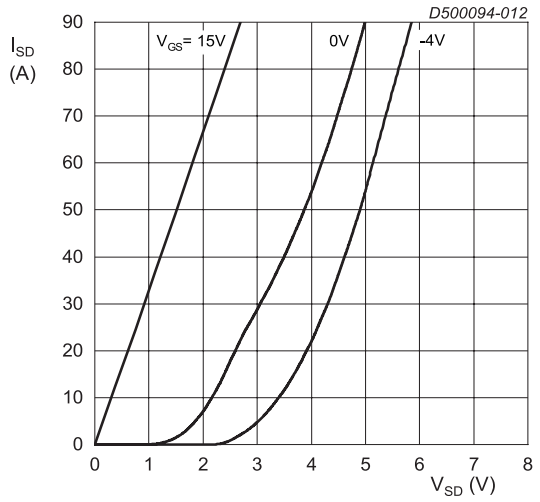
T_j = -40 °C; t_p < 200 µs

Fig. 10. Body diode forward characteristics; typical values



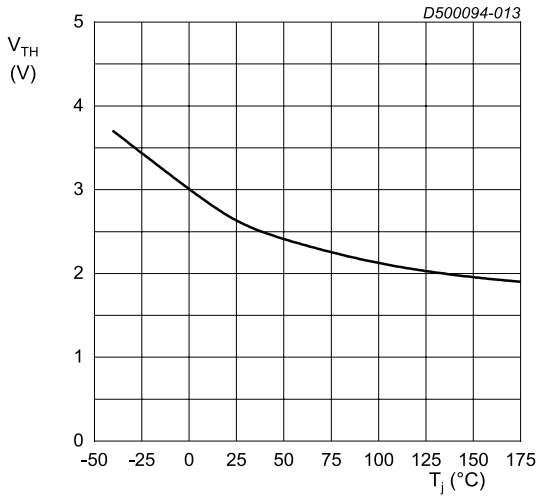
T_j = 25 °C; t_p < 200 µs

Fig. 11. Body diode forward characteristics; typical values



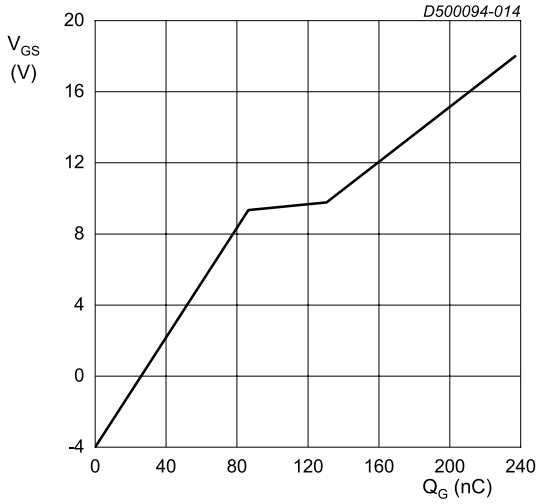
T_j = 150 °C; t_p < 200 µs

Fig. 12. Body diode forward characteristics; typical values



V_{DS} = 10 V; I_{DS} = 20 mA

Fig. 13. Threshold voltage as a function of junction temperature



I_{DS} = 50 A; I_{GS} = 0.1 mA; V_{DS} = 800 V; T_j = 25 °C

Fig. 14. Gate-source voltage as a function of gate charge; typical values

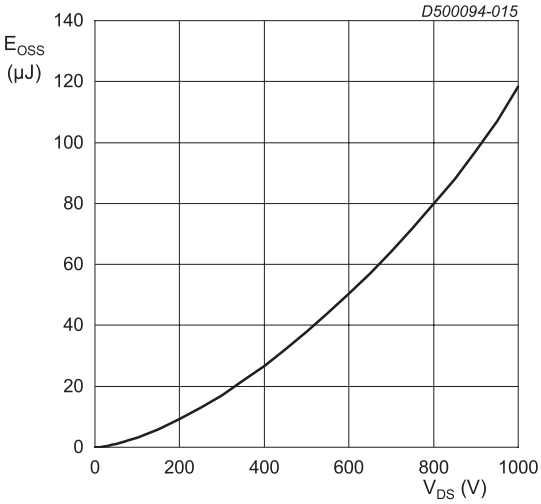
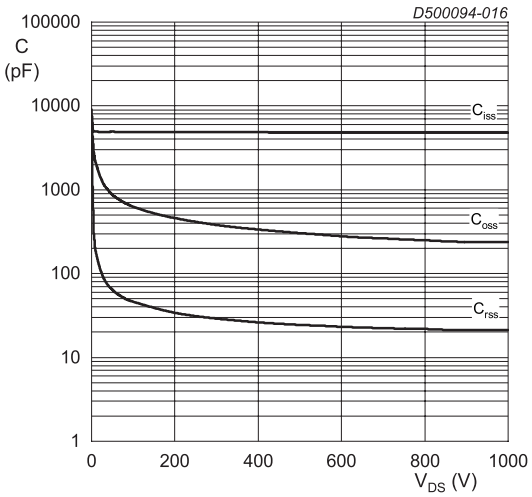
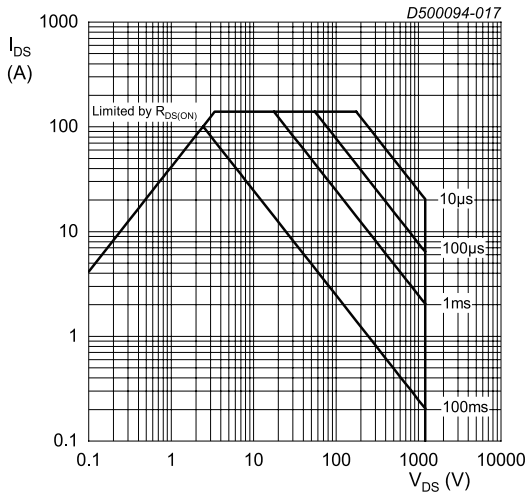


Fig. 15. Output capacitor stored energy as a function of drain-source voltage



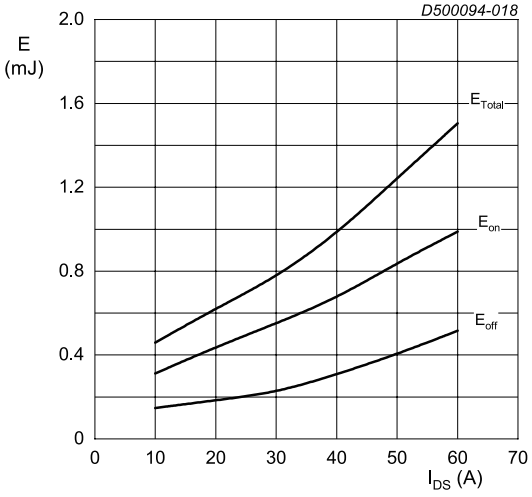
V_{DS} = 0 - 1000 V
T_j = 25 °C; V_{AC} = 25 mV; f = 100 KHz

Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values



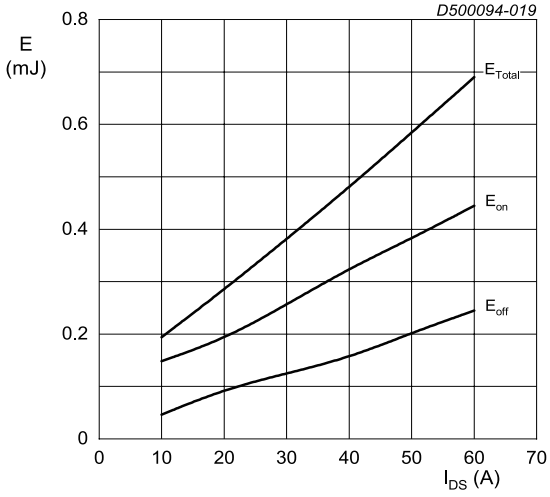
T_j = 25 °C; D = 0
Parameter: t_p

Fig. 17. Forward bias safe operating area



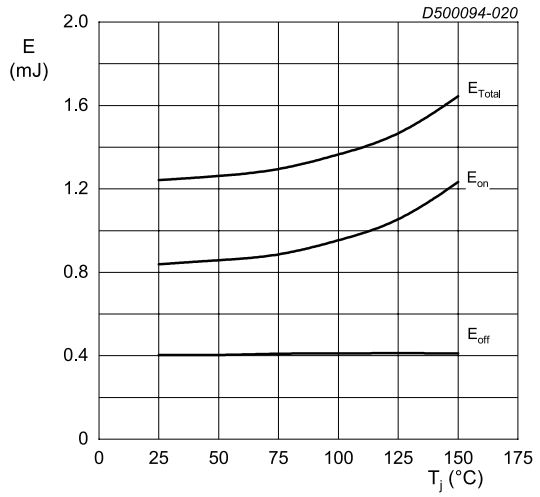
T_j = 25 °C; V_{DD} = 800 V; $R_{G(off)}$ = 2.4 Ω; $R_{G(on)}$ = 2.4 Ω; V_{GS} = -4 V/18 V; L = 100 µH

Fig. 18. Clamped Inductive Switching Energy as a function of drain current



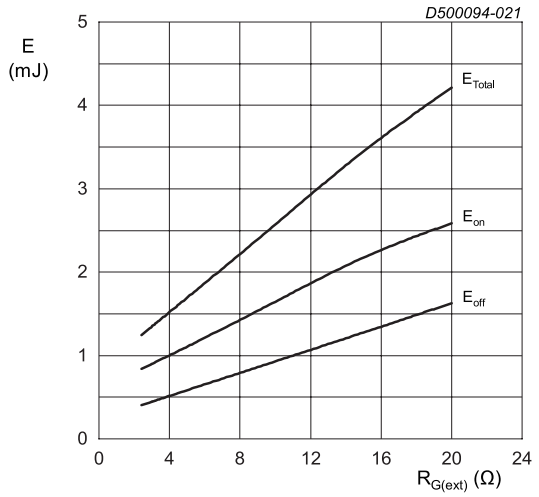
T_j = 25 °C; V_{DD} = 600 V; $R_{G(off)}$ = 2.4 Ω; $R_{G(on)}$ = 2.4 Ω; V_{GS} = -4 V/18 V; L = 100 µH

Fig. 19. Clamped Inductive Switching Energy as a function of drain current



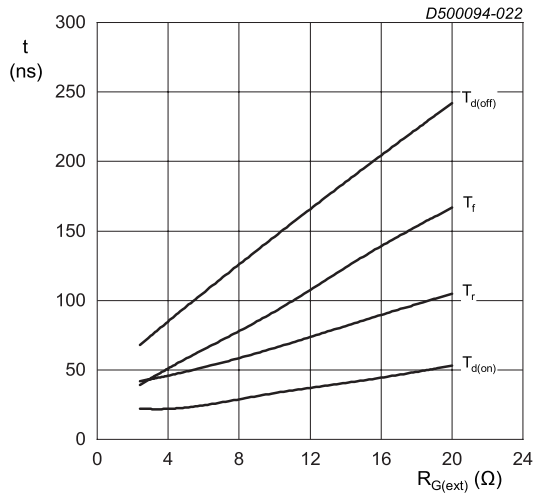
I_{DS} = 50 A; V_{DD} = 800 V; $R_{G(off)}$ = 2.4 Ω; $R_{G(on)}$ = 2.4 Ω; V_{GS} = -4 V/18 V; L = 100 µH

Fig. 20. Clamped Inductive Switching Energy as a function of junction temperature



T_j = 25 °C; V_{DD} = 800 V; I_{DS} = 50 A; V_{GS} = -4 V/18 V; L = 100 µH

Fig. 21. Clamped Inductive Switching Energy as a function of external gate resistance



T_j = 25 °C; V_{DD} = 800 V; I_{DS} = 50 A; V_{GS} = -4 V/18 V; L = 100 µH

Fig. 22. Switching time as a function of external gate resistance

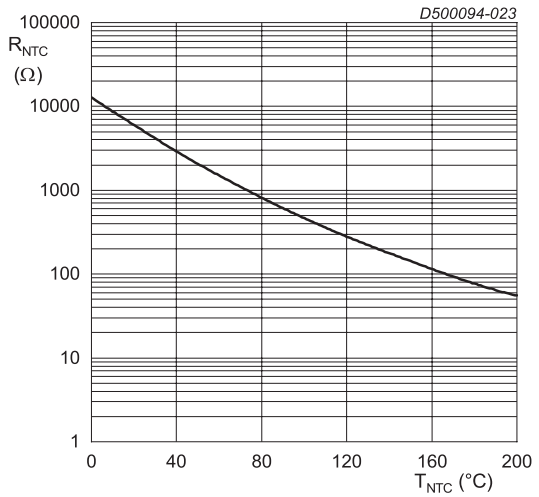
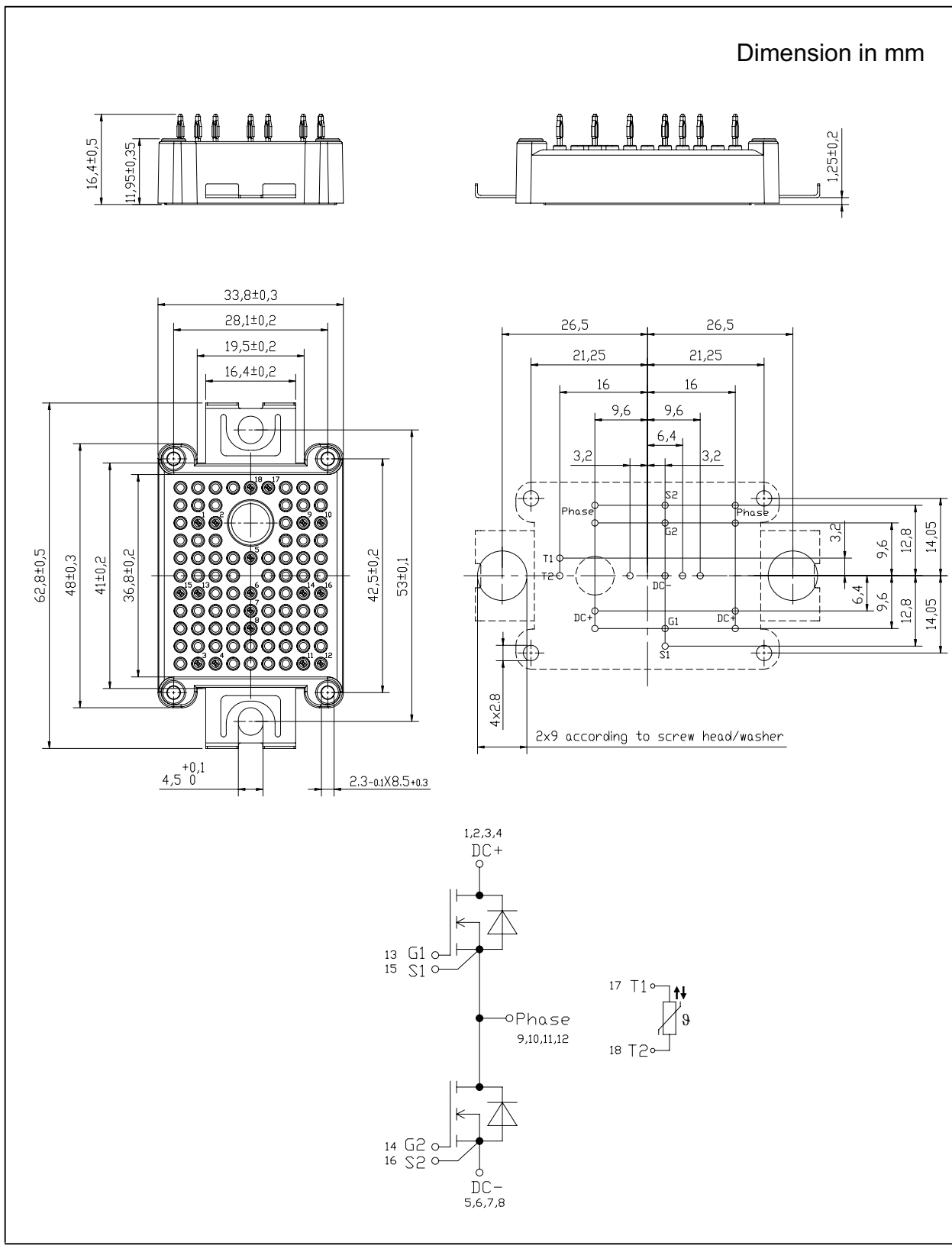


Fig. 23. NTC thermistor resistance as a function of NTC temperature

11. Package outline

WeEnPACK-B1PHB-A

Dimension in mm



12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.
[2] The term 'short data sheet' is explained in section "Definitions".
[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.ween-semi.com.

Definitions

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. WeEn Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local WeEn Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between WeEn Semiconductors and its customer, unless WeEn Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the WeEn Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, WeEn Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. WeEn Semiconductors takes no responsibility for the content in this document if provided by an information source outside of WeEn Semiconductors.

In no event shall WeEn Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including - without limitation - lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, WeEn Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the *Terms and conditions of commercial sale* of WeEn Semiconductors.

Right to make changes — WeEn Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — WeEn Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an WeEn Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. WeEn Semiconductors and its suppliers accept no liability for inclusion and/or use of WeEn Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. WeEn Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Customers are responsible for the design and operation of their applications and products using WeEn Semiconductors products, and WeEn Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the WeEn Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

WeEn Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using WeEn Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). WeEn does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Non-automotive qualified products — Unless this data sheet expressly states that this specific WeEn Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. WeEn Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without WeEn Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond WeEn Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies WeEn Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond WeEn Semiconductors' standard warranty and WeEn Semiconductors' product specifications.

Translations — A non-English (translated) version of a document is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

13. Contents

For more information, please visit: http://www.ween-semi.com
For sales office addresses, please send an email to: salesaddresses@ween-semi.com
Date of release: 24 September 2024